

Search Notes**Application/Control No.**

10/734,905

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	2	3/5/2005	JSL
716	16	3/5/2005	JSL
716	17	3/5/2005	JSL
716	18	3/5/2005	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IEEE	3/3/2005	JSL
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	3/5/2005	JSL
GOOGLE	3/5/2005	JSL
IEEE	3/5/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
